

IGBT – Power, Co-PAK **N-Channel, Field Stop VII** (FS7), TO247-4L 1200 V, 1.7 V, 100 A

FGY4L100T120SWD

Description

Using the novel field stop 7th generation IGBT technology and the Gen7 Diode in TO247 4-lead package, FGY4L100T120SWD offers the optimum performance with low switching and conduction losses for high-efficiency operations in various applications like Solar Inverter, UPS and ESS.

Features

- Maximum Junction Temperature T_J = 175°C
- Positive Temperature Coefficient for Easy Parallel Operation
- High Current Capability
- Smooth and Optimized Switching
- Low Switching Loss
- RoHS Compliant

Applications

- Solar Inverter
- UPS
- Energy Storage System

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

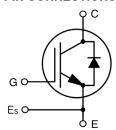
Paran	Symbol	Value	Unit	
Collector-to-Emitter Vol	V_{CE}	1200	٧	
Gate-to-Emitter Voltage	•	V_{GE}	±20	
Transient Gate-to-Emitt	er Voltage	1	±30	
Collector Current	T _C = 25°C (Note 1)	I _C	200	Α
	T _C = 100°C	1	100	
Power Dissipation	T _C = 25°C	P_{D}	1071	W
	T _C = 100°C	1	536	
Pulsed Collector Current	$T_C = 25^{\circ}C,$ $t_p = 10 \ \mu s \ (Note 2)$	I _{CM}	400	Α
Diode Forward T _C = 25°C (Note 1)		IF	200	
Current $T_C = 100^{\circ}C$		1	100	
Pulsed Diode Forward Current	biode Forward $T_C = 25^{\circ}C$, $t_p = 10 \mu s$ (Note 2)		400	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +175	°C
Lead Temperature for So	T_L	265		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Value limited by bond wire
- 2. Repetitive rating: Pulse width limited by max. junction temperature.

BV _{CES}	V _{CE(SAT)_TYP}	lc
1200 V	1.7 V	100 A

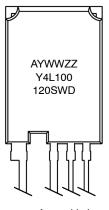
PIN CONNECTIONS





TO-247-4LD CASE 340BW

MARKING DIAGRAM



= Assembly Location YWW = Date code (Year & week) = Assembly Lot Y4L100120SWD = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping
FGY4L100T120SWD	TO-247-4LD (Pb-Free)	30 Units / Tube

THERMAL CHARACTERISTICS

		Value			
Parameter	Symbol	Min	Тур	Max	Unit
Thermal Resistance, Junction-to-Case for IGBT	$R_{ heta JC}$	_	0.11	0.14	°C/W
Thermal Resistance, Junction-to-Case for Diode	$R_{\theta JCD}$	_	0.22	0.29	
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	-	_	40	

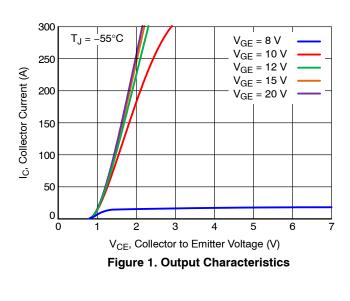
$\textbf{ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}C \ unless \ otherwise \ noted)$

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Collector-to-Emitter Breakdown Voltage	BV _{CES}	$V_{GE} = 0 \text{ V}, I_{C} = 1 \text{ mA}$	1200	_	-	V
Breakdown Voltage Temperature Coefficient	ΔBV_CES	$V_{GE} = 0 \text{ V}, I_{C} = 9.99 \text{ mA}$	_	1220	-	mV/°C
	ΔT_{J}					
Collector-to-Emitter Cut-Off Current	I _{CES}	V _{GE} = 0 V, V _{CE} = V _{CES}	-	_	40	μΑ
Gate-to-Emitter Leakage Current	I _{GES}	$V_{GE} = \pm 20 \text{ V}, V_{CE} = 0 \text{ V}$	-	_	±400	nA
ON CHARACTERISTICS	•					•
Gate-to-Emitter Threshold Voltage	V _{GE(th)}	$V_{GE} = V_{CE}$, $I_C = 100 \text{ mA}$	5.6	6.5	7.4	V
Collector-to-Emitter Saturation Voltage	V _{CE(sat)}	V _{GE} = 15 V, I _C = 100 A, T _J = 25°C	-	1.7	2.0	1
		V _{GE} = 15 V, I _C = 100 A, T _J = 175°C	-	2.4	-	1
DYNAMIC CHARACTERISTICS	•					
Input Capacitance	C _{ies}	V _{CE} = 30 V, V _{GE} = 0 V, f = 1 MHz	-	9640	-	pF
Output Capacitance	C _{oes}		1	287	-	1
Reverse Transfer Capacitance	C _{res}		1	40.1	-	1
Total Gate Charge	Q_g	V _{CE} = 600 V, V _{GE} = 15 V, I _C = 100 A	1	308	-	nC
Gate-to-Emitter Charge	Q _{ge}	I _C = 100 A	1	86	-	1
Gate-to-Collector Charge	Q _{gc}	1	1	110	-	1
SWITCHING CHARACTERISTIC, INDUCTIV	E LOAD					
Turn-on Delay Time	t _{d(on)}	V_{CE} = 600 V, V_{GE} = 15 V I_{C} = 50 A R_{G} = 7 Ω T_{J} = 25°C	-	56	-	ns
Rise Time	t _r	$I_{\rm C} = 50 \text{ A H}_{\rm G} = 7 \Omega I_{\rm J} = 25 ^{\circ} \text{C}$	-	17.6	-	1
Turn-off Delay Time	t _{d(off)}		-	272.4	-	1
Fall Time	t _f		-	80	-	1
Turn-on Switching Loss	E _{on}		-	1.7	-	mJ
Turn-off Switching Loss	E _{off}		-	1.9	-] !
Total Switching Loss	E _{ts}		-	3.6	-	
Turn-on Delay Time	t _{d(on)}	V _{CE} = 600 V, V _{GE} = 15 V	-	59.2	-	ns
Rise Time	t _r	$I_{C} = 100 \text{ A R}_{G} = 7 \Omega T_{J} = 25^{\circ}\text{C}$	-	25.6	-	
Turn-off Delay Time	t _{d(off)}		-	232.4	-	
Fall Time	t _f]	-	73.6	-	
Turn-on Switching Loss	E _{on}]	-	2.8	-	mJ
Turn-off Switching Loss	E _{off}]	-	3.5	-	
Total Switching Loss	E _{ts}]	-	6.3	-]

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted) (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
SWITCHING CHARACTERISTIC, INDUC	TIVE LOAD					
Turn-on Delay Time	t _{d(on)}	V _{CE} = 600 V, V _{GE} = 15 V	_	44.8	-	ns
Rise Time	t _r	$I_{\rm C} = 50 \text{ A R}_{\rm G} = 7 \Omega T_{\rm J} = 175 ^{\circ} \text{C}$	_	22.4	-	1
Turn-off Delay Time	t _{d(off)}		_	324.8	-	
Fall Time	t _f		_	147.2	-	
Turn-on Switching Loss	E _{on}		_	3.6	-	mJ
Turn-off Switching Loss	E _{off}		-	3.1	-	1
Total Switching Loss	E _{ts}		_	6.7	-	1
Turn-on Delay Time	t _{d(on)}	V _{CE} = 600 V, V _{GE} = 15 V	-	49.6	-	ns
Rise Time	t _r	$I_C = 100 \text{ A R}_G = 7 \Omega T_J = 175^{\circ}\text{C}$	_	32	-	1
Turn-off Delay Time	t _{d(off)}		_	276.8	-	1
Fall Time	t _f		_	128	-	1
Turn-on Switching Loss	E _{on}		_	6.1	-	mJ
Turn-off Switching Loss	E _{off}		_	5.1	-	
Total Switching Loss	E _{ts}		_	11.2	-	
DIODE CHARACTERISTICS						
Forward Voltage	V _F	I _F = 100 A, T _J = 25°C	1.74	2.04	2.34	V
		I _F = 100 A, T _J = 175°C	-	2.2	-	
DIODE SWITCHING CHARACTERISTIC	S, INDUCTIVE LO	DAD				
Reverse Recovery Time	t _{rr}	$V_R = 600 \text{ V, } I_F = 50 \text{ A,}$ $dI_F/dt = 1000 \text{ A/}\mu\text{s, } T_J = 25^{\circ}\text{C}$	-	167.2	-	ns
Reverse Recovery Charge	Q _{rr}		-	3.2	-	μC
Reverse Recovery Energy	E _{REC}		-	1.0	-	mJ
Peak Reverse Recovery Current	I _{RRM}		-	38.7	-	Α
Reverse Recovery Time	t _{rr}	V _R = 600 V, I _F = 100 A,	-	249.4	-	ns
Reverse Recovery Charge	Q _{rr}	dl _F /dt = 1000 A/μs, T _J = 25°C	-	5.5	-	μC
Reverse Recovery Energy	E _{REC}		-	1.8	-	mJ
Peak Reverse Recovery Current	I _{RRM}		_	43.8	-	Α
Reverse Recovery Time	t _{rr}	$V_R = 600 \text{ V, } I_F = 50 \text{ A,}$ $dI_F/dt = 1000 \text{ A/}\mu\text{s, } T_J = 175^{\circ}\text{C}$	-	281.4	-	ns
Reverse Recovery Charge	Q _{rr}		_	7.8	-	μC
Reverse Recovery Energy	E _{REC}		-	2.8	-	mJ
Peak Reverse Recovery Current	I _{RRM}		_	55.5	-	Α
Reverse Recovery Time	t _{rr}	$V_{R} = 600 \text{ V, I}_{F} = 100 \text{ A,}$ $dI_{F}/dt = 1000 \text{ A/}\mu\text{s, T}_{J} = 175^{\circ}\text{C}$	-	413.4	-	ns
Reverse Recovery Charge	Q _{rr}		_	12.2	-	μC
Reverse Recovery Energy	E _{REC}		_	4.5	-	mJ
Peak Reverse Recovery Current	I _{RRM}		_	58.9	-	Α

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



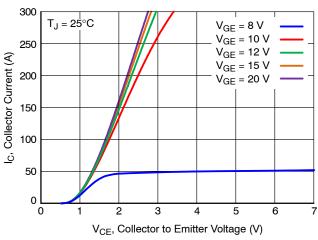
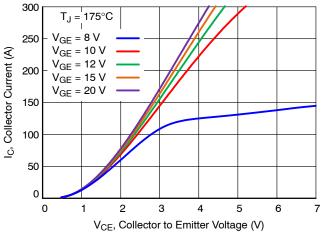


Figure 2. Output Characteristics



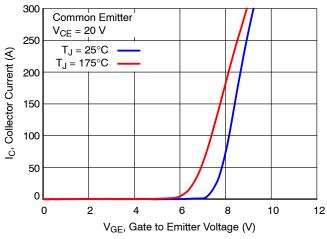
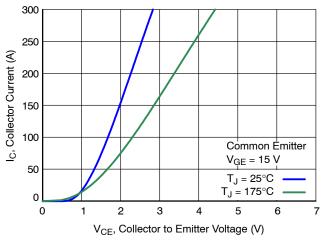


Figure 3. Output Characteristics

Figure 4. Transfer Characteristics



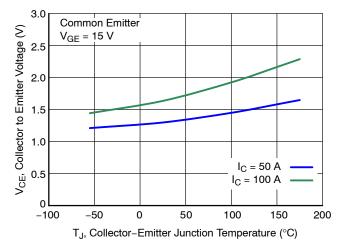


Figure 5. Saturation Characteristics

Figure 6. Saturation Voltage vs. Junction Temperature

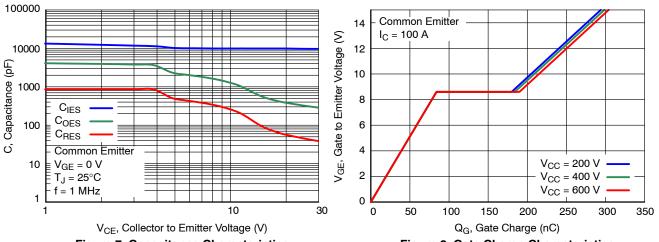


Figure 7. Capacitance Characteristics

Figure 8. Gate Charge Characteristics

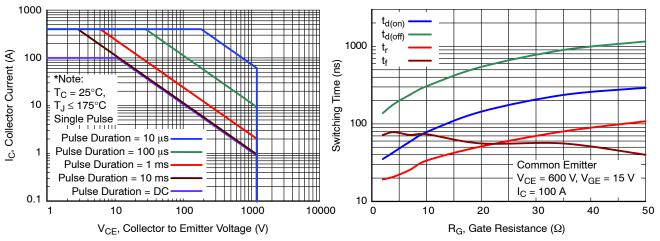


Figure 9. SOA Characteristics

Figure 10. Switching Time vs. Gate Resistance $(T_J = 25^{\circ}C)$

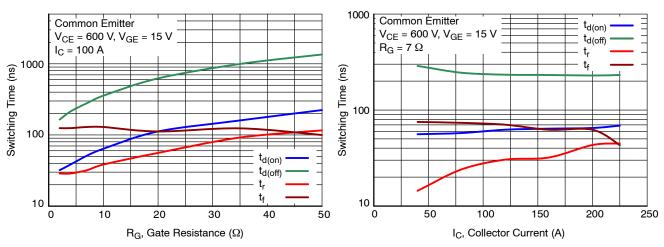


Figure 11. Switching Time vs. Gate Resistance $(T_J = 175$ °C)

Figure 12. Switching Time vs. Collector Current $(T_J = 25^{\circ}C)$

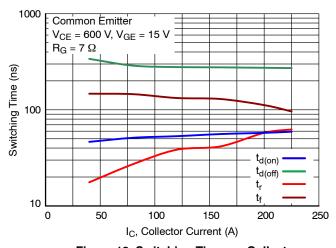


Figure 13. Switching Time vs. Collector Current ($T_J = 175$ °C)

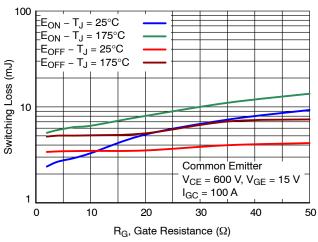


Figure 14. Switching Loss vs Gate Resistance

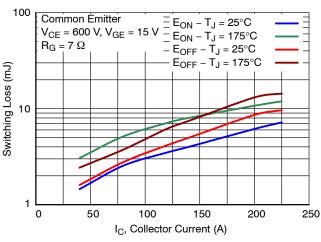


Figure 15. Switching Loss vs. Collector Current

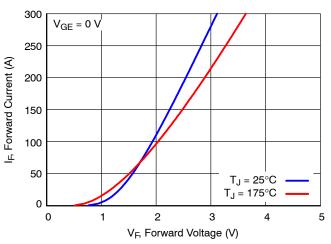


Figure 16. Diode Forward Characteristics

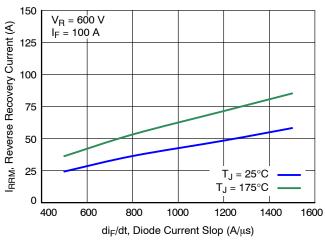


Figure 17. Diode Reverse Recovery Current

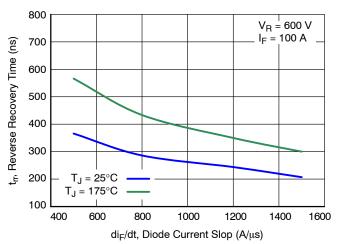


Figure 18. Diode Reverse Recovery Time

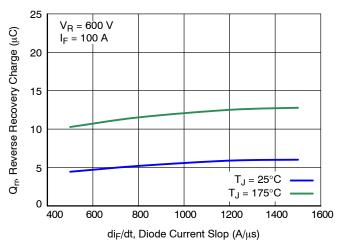


Figure 19. Diode Stored Charge

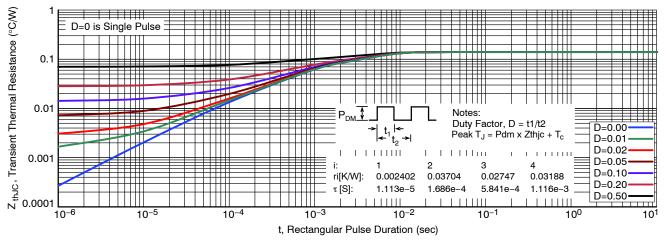


Figure 20. Max Transient Thermal Impedance of IGBT

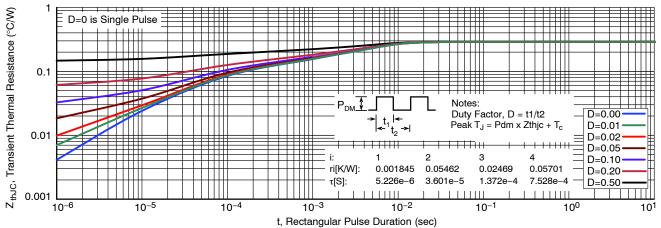
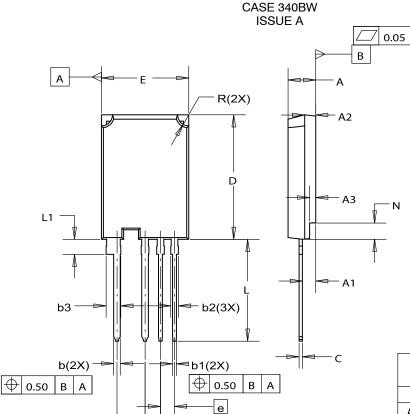


Figure 21. Max Transient Thermal Impedance of Diode

PACKAGE DIMENSIONS

TO-247-PLUS-4L 15.80x22.54x5.00, 2.54P



NOTES:

e2

A. NO INDUSTRY STANDARS APPLIES TO THIS PACKAGE. B. ALL DIMENSIONS ARE IN MILLIMETERS.

C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

D. DRAWING CONFORMS TO ASME Y14.5-2009.

MILLIMETERS				
MIN	NOM	MAX		
4.80	5.00	5.20		
2.21	2.41	2.61		
1.80	2.00	2.20		
1.00	1.10	1.20		
1.07	1.20	1.33		
0.57	0.70	0.83		
1.20	1.40	1.60		
2.47	2.67	2.87		
0.50	0.60	0.70		
22.34	22.54	22.74		
16.00	16.20	16.40		
0.96	1.16	1.36		
1.52	1.72	1.92		
2.54BSC				
2.79BSC				
5.08BSC				
15.60	15.80	16.00		
13.10	13.30	13.50		
18.12	18.42	18.72		
2.52	2.72	2.92		
1.90	2.00	2.10		
2.75	2.95	3.15		
	MIN 4.80 2.21 1.80 1.00 1.07 0.57 1.20 2.47 0.50 22.34 16.00 0.96 1.52 25 15.60 13.10 18.12 2.52 1.90	MIN NOM 4.80 5.00 2.21 2.41 1.80 2.00 1.00 1.10 1.07 1.20 0.57 0.70 1.20 1.40 2.47 2.67 0.50 0.60 22.34 22.54 16.00 16.20 0.96 1.16 1.52 1.72 2.54BSC 2.79BSC 5.08BSC 15.60 15.10 13.30 18.12 18.42 2.52 2.72 1.90 2.00		

- E1 -

- D2

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